# International Rectifier

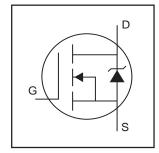
#### HEXFET® Power MOSFET

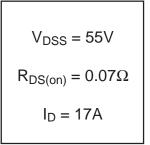
- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated

#### **Description**

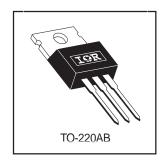
Fifth Generation HEXFET® power MOSFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.





IRFZ24N



#### **Absolute Maximum Ratings**

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	17	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	12	A
I <sub>DM</sub>	Pulsed Drain Current ①	68	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	45	W
	Linear Derating Factor	0.30	W/°C
$V_{GS}$	Gate-to-Source Voltage	±20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy ②	71	mJ
I <sub>AR</sub>	Avalanche Current①	10	A
E <sub>AR</sub>	Repetitive Avalanche Energy①	4.5	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 screw.	10 lbf•in (1.1N•m)	

#### **Thermal Resistance**

	Parameter	Min.	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case			3.3	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface		0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient			62	

## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions		
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$		
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.052		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA		
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.07	Ω	V <sub>GS</sub> = 10V, I <sub>D</sub> = 10A ④		
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$		
9 <sub>fs</sub>	Forward Transconductance	4.5			S	$V_{DS} = 25V, I_{D} = 10A$		
1	Drain to Course Leekage Current			25	μA	$V_{DS} = 55V, V_{GS} = 0V$		
I <sub>DSS</sub>	Drain-to-Source Leakage Current			250	μΑ	V <sub>DS</sub> = 44V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 150°C		
1	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V		
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100	IIA	V <sub>GS</sub> = -20V		
Qg	Total Gate Charge			20		I <sub>D</sub> = 10A		
Q <sub>gs</sub>	Gate-to-Source Charge			5.3	nC	$V_{DS} = 44V$		
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge			7.6		V <sub>GS</sub> = 10V, See Fig. 6 and 13 ④		
t <sub>d(on)</sub>	Turn-On Delay Time		4.9			V <sub>DD</sub> = 28V		
t <sub>r</sub>	Rise Time		34			$I_D = 10A$		
t <sub>d(off)</sub>	Turn-Off Delay Time		19		ns	$R_G = 24\Omega$		
t <sub>f</sub>	Fall Time		27			$R_D = 2.6\Omega$ , See Fig. 10 $ ext{ }  e$		
L <sub>D</sub>	Internal Drain Inductance		- 4.5		Between lead,			
					nH	6mm (0.25in.)		
	Internal Source Inductance —	7.5			111	from package		
L <sub>S</sub>			7.5			and center of die contact		
C <sub>iss</sub>	Input Capacitance		370			V <sub>GS</sub> = 0V		
C <sub>oss</sub>	Output Capacitance		140		pF	$V_{DS} = 25V$		
C <sub>rss</sub>	Reverse Transfer Capacitance		65			f = 1.0MHz, See Fig. 5		

### **Source-Drain Ratings and Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions			
Is	Continuous Source Current			17		MOSFET symbol			
	(Body Diode)			17	Α	showing the			
I <sub>SM</sub>	Pulsed Source Current			68	, ,	integral reverse			
	(Body Diode) ①				- 00	- 00	00		p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage			1.3	V	$T_J = 25$ °C, $I_S = 10$ A, $V_{GS} = 0$ V ④			
t <sub>rr</sub>	Reverse Recovery Time		56	83	ns	$T_J = 25$ °C, $I_F = 10$ A			
Q <sub>rr</sub>	Reverse RecoveryCharge		120	180	nC	di/dt = 100A/µs ④			

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- $\begin{tabular}{ll} @V_{DD}=25V, \ starting \ T_J=25^{\circ}C, \ L=1.0mH\\ R_G=25\Omega, \ I_{AS}=10A. \ (See \ Figure \ 12) \\ \end{tabular}$
- $\begin{tabular}{ll} \begin{tabular}{ll} \be$
- 4 Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .

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## IRFZ24N

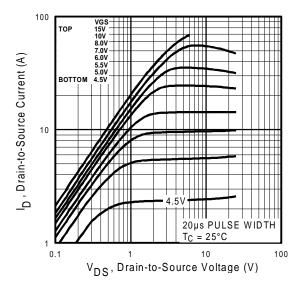


Fig 1. Typical Output Characteristics,  $T_J = 25^{\circ}C$ 

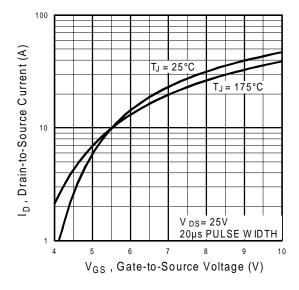


Fig 3. Typical Transfer Characteristics

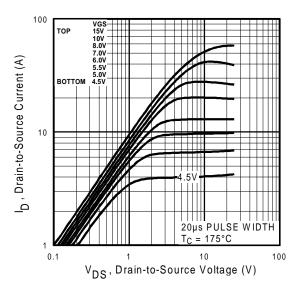
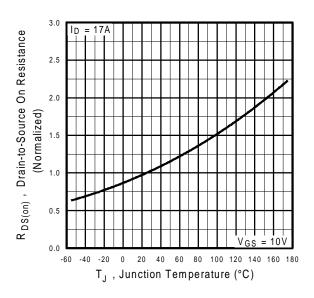
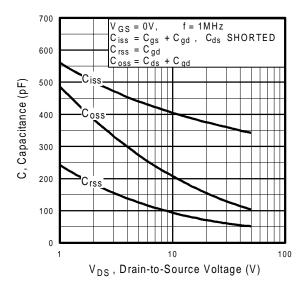


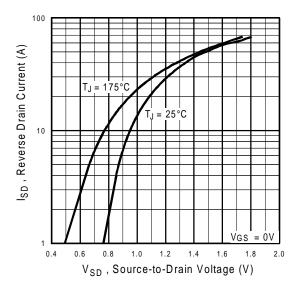
Fig 2. Typical Output Characteristics,  $T_J = 175^{\circ}C$ 



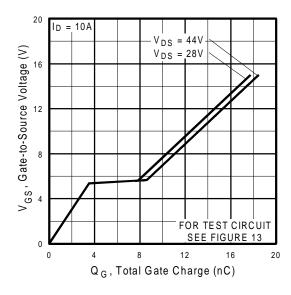
**Fig 4.** Normalized On-Resistance Vs. Temperature



**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage

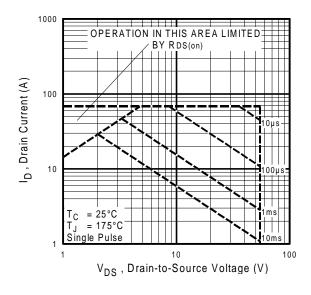
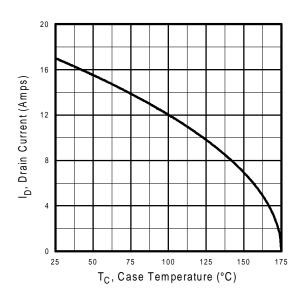


Fig 8. Maximum Safe Operating Area

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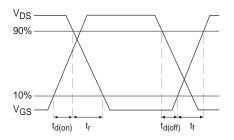
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 $V_{DS} \longrightarrow V_{DS}$   $V_{GS} \longrightarrow D.U.T.$   $R_{G} \longrightarrow D.U.T.$   $V_{DD} \longrightarrow V_{DD}$   $V_{DS} \longrightarrow D.U.T.$   $V_{DD} \longrightarrow V_{DD}$   $V_{DS} \longrightarrow D.U.T.$   $V_{DD} \longrightarrow V_{DD}$   $V_{DS} \longrightarrow V_{DS}$   $V_{DS} \longrightarrow V_$ 

Fig 10a. Switching Time Test Circuit



**Fig 9.** Maximum Drain Current Vs. Case Temperature

Fig 10b. Switching Time Waveforms

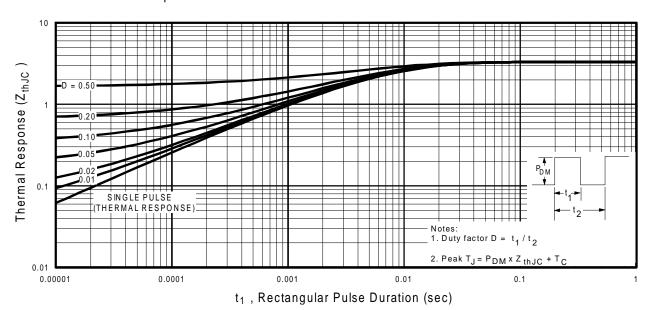


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

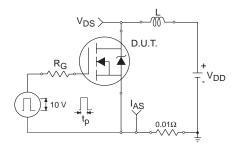


Fig 12a. Unclamped Inductive Test Circuit

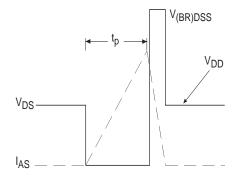


Fig 12b. Unclamped Inductive Waveforms

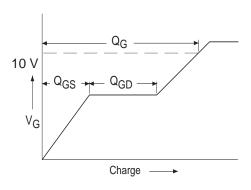
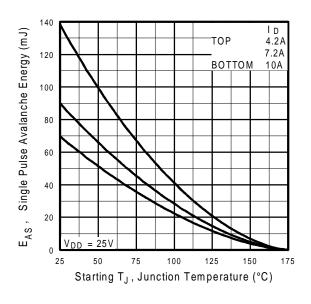


Fig 13a. Basic Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

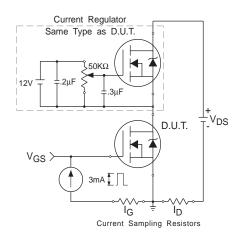
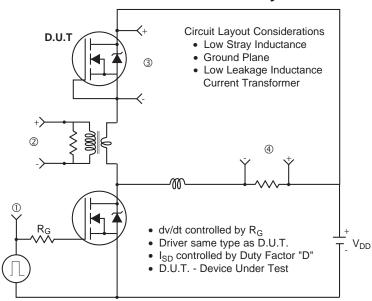


Fig 13b. Gate Charge Test Circuit

### Peak Diode Recovery dv/dt Test Circuit



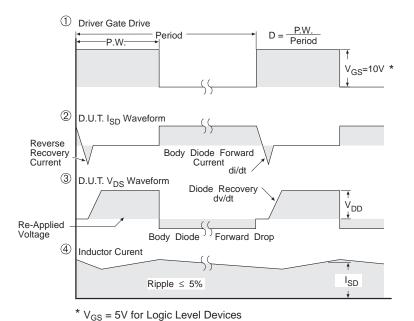


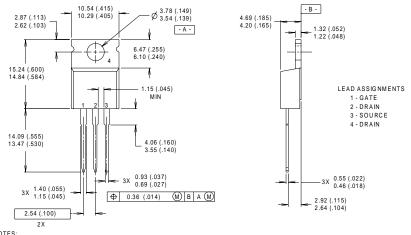
Fig 14. For N-Channel HEXFET® power MOSFETs

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## Package Outline

TO-220AB

Dimensions are shown in millimeters (inches)



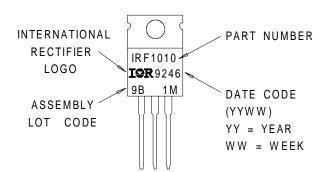
NOTES:

- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
- 2 CONTROLLING DIMENSION : INCH
- 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220-AB.
  4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

# Part Marking Information TO-220AB

EXAMPLE: THIS IS AN IRF1010

WITH ASSEMBLY LOT CODE 9B1M



# International \*\*Example Rectifier\*\*

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IR CANADA: 15 Lincoln Court, Brampton, Ontario L6T3Z2, Tel: (905) 453 2200

IR GERMANY: Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590

IR ITALY: Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

IR FAR EAST: K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo Japan 171 Tel: 81 3 3983 0086 IR SOUTHEAST ASIA: 1 Kim Seng Promenade, Great World City West Tower, 13-11, Singapore 237994 Tel: ++ 65 838 4630 IR TAIWAN:16 Fl. Suite D. 207, Sec. 2, Tun Haw South Road, Taipei, 10673, Taiwan Tel: 886-2-2377-9936 http://www.irf.com/ Data and specifications subject to change without notice. 9/99

Note: For the most current drawings please refer to the IR website at: <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>